

# PH2920

N-channel enhancement mode field-effect transistor

Rev. 01 — 13 June 2003

Product data

## 1. Product profile

### 1.1 Description

N-channel enhancement mode field-effect power transistor in a SOT669 (LFAK) package.

Product availability:

PH2920 in SOT669 (LFAK).

### 1.2 Features

- Low thermal resistance
- Low gate drive current
- SO8 equivalent area footprint
- Low on-state resistance.

### 1.3 Applications

- DC-to-DC converters
- Portable appliances
- Switched mode power supplies
- Notebook computers.

### 1.4 Quick reference data

- $V_{DS} \leq 20 \text{ V}$
- $P_{tot} \leq 62.5 \text{ W}$
- $I_D \leq 60 \text{ A}$
- $R_{DSon} \leq 2.9 \text{ m}\Omega$

## 2. Pinning information

Table 1: Pinning - SOT669 (LFAK), simplified outline and symbol

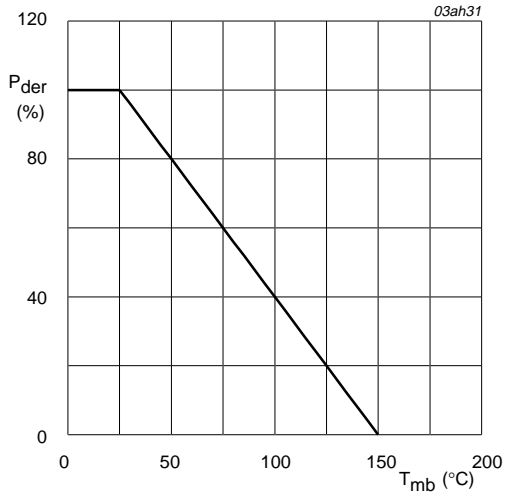
Pin	Description	Simplified outline	Symbol
1,2,3	source (s)	<p style="text-align: center;">SOT669 (LFAK)</p>	
4	gate (g)		
mb	drain (d)		

### 3. Limiting values

**Table 2: Limiting values**

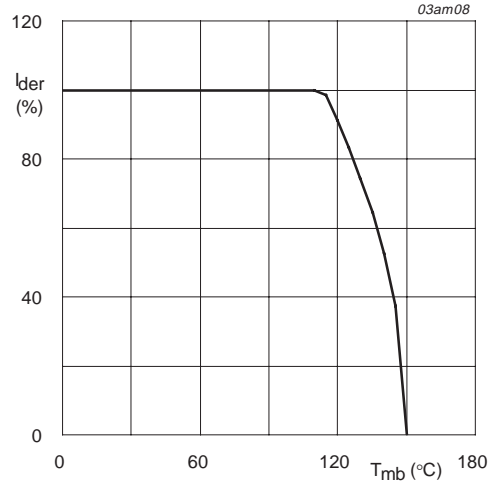
*In accordance with the Absolute Maximum Rating System (IEC 60134).*

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage (DC)	$T_j = 25$ to $150$ °C	-	20	V
$V_{GS}$	gate-source voltage (DC)		-	$\pm 20$	V
$I_D$	drain current (DC)	$T_{mb} = 25$ °C; $V_{GS} = 10$ V; <b>Figure 2 and 3</b>	-	60	A
$I_{DM}$	peak drain current	$T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ $\mu$ s; <b>Figure 3</b>	-	240	A
$P_{tot}$	total power dissipation	$T_{mb} = 25$ °C; <b>Figure 1</b>	-	62.5	W
$T_{stg}$	storage temperature		-55	+150	°C
$T_j$	junction temperature		-55	+150	°C
<b>Source-drain diode</b>					
$I_S$	source (diode forward) current (DC)	$T_{mb} = 25$ °C	-	60	A
$I_{SM}$	peak source (diode forward) current	$T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ $\mu$ s	-	240	A



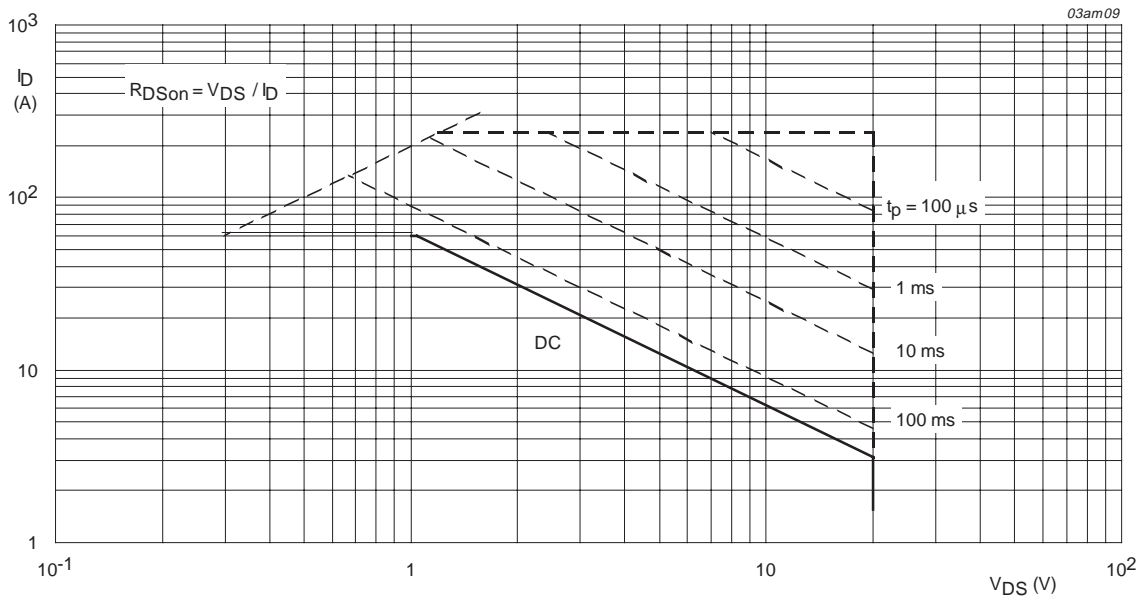
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



$T_{mb} = 25^{\circ}C$ ;  $I_{DM}$  is single pulse.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

## 4. Thermal characteristics

Table 3: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base		-	-	2	K/W

### 4.1 Transient thermal impedance

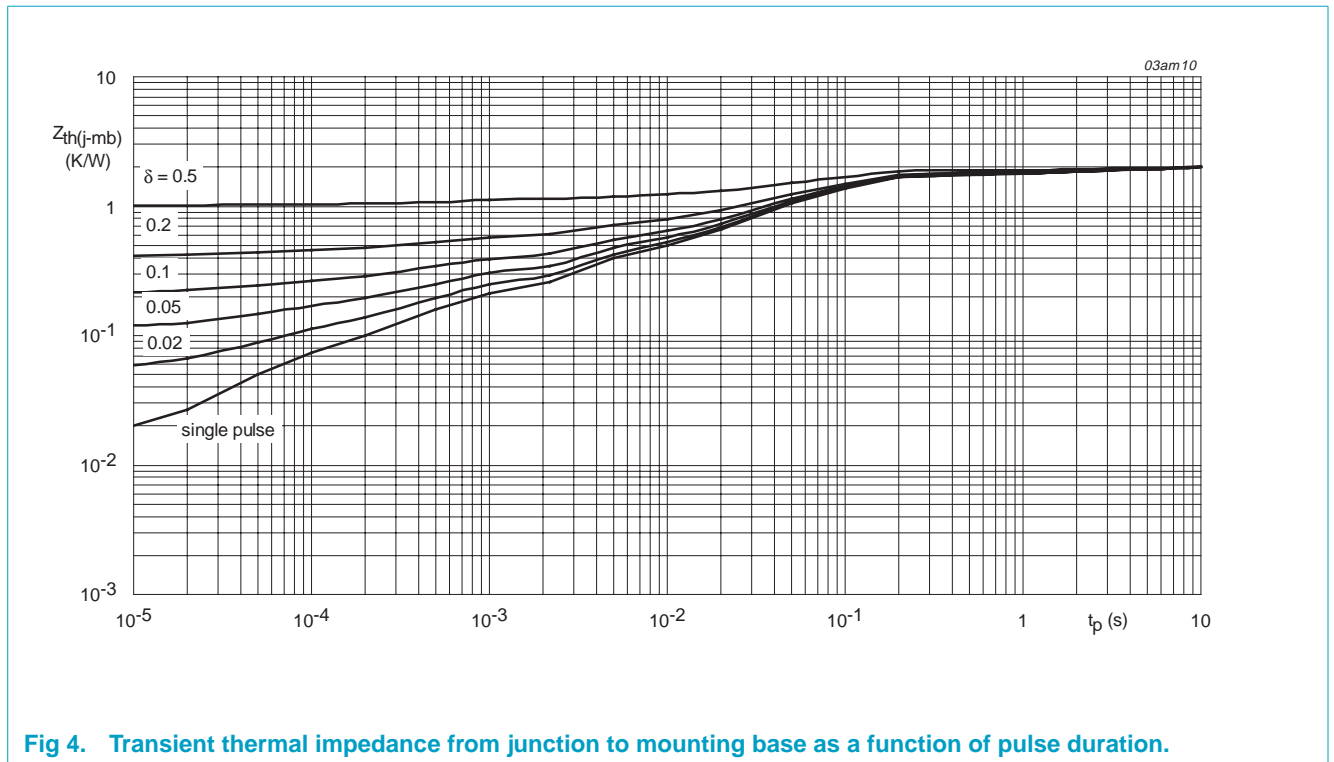


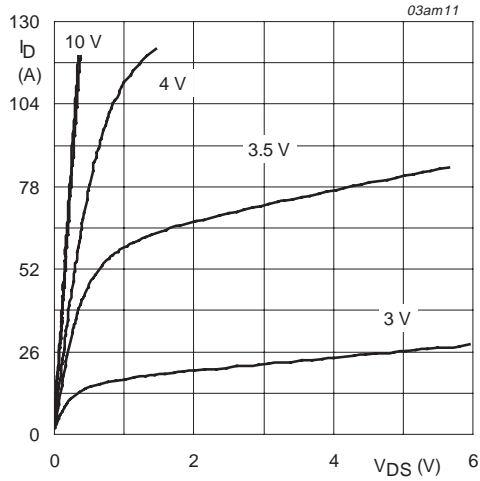
Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

## 5. Characteristics

**Table 4: Characteristics**

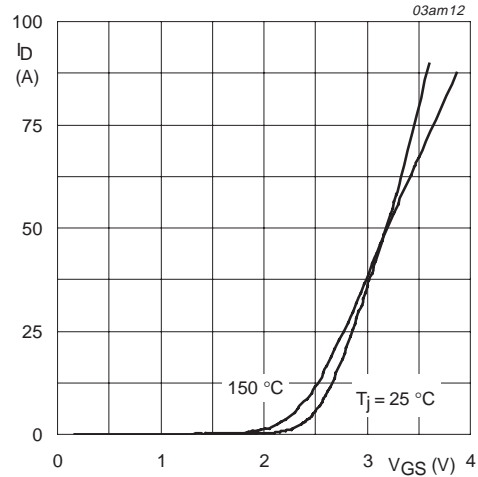
$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 10\text{ mA}; V_{GS} = 0\text{ V}$	20	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1\text{ mA}; V_{DS} = V_{GS}$ ; <b>Figure 9</b>	1	1.75	2.5	V
$I_{DSS}$	drain-source leakage current	$V_{DS} = 20\text{ V}; V_{GS} = 0\text{ V}; T_j = 25\text{ }^\circ\text{C}$	-	0.06	1	$\mu\text{A}$
$I_{GSS}$	gate-source leakage current	$V_{GS} = \pm 16\text{ V}; V_{DS} = 0\text{ V}$	-	-	10	$\mu\text{A}$
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 10\text{ V}; I_D = 30\text{ A}$ ; <b>Figure 7 and 8</b>	-	2.6	2.9	$\text{m}\Omega$
		$V_{GS} = 4.5\text{ V}; I_D = 30\text{ A}$	-	4.3	5.8	$\text{m}\Omega$
<b>Dynamic characteristics</b>						
$g_{fs}$	forward transconductance	$V_{DS} = 10\text{ V}; I_D = 30\text{ A}$	45	75	-	S
$Q_{g(tot)}$	total gate charge	$I_D = 60\text{ A}; V_{DD} = 10\text{ V}; V_{GS} = 10\text{ V}$ ; <b>Figure 13</b>	-	60	-	nC
$Q_{gs}$	gate-source charge		-	15	-	nC
$Q_{gd}$	gate-drain (Miller) charge		-	11	-	nC
$C_{iss}$	input capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 10\text{ V}; f = 1\text{ MHz}$ ; <b>Figure 11</b>	-	4200	-	pF
$C_{oss}$	output capacitance		-	1200	-	pF
$C_{riss}$	reverse transfer capacitance		-	650	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DD} = 10\text{ V}; I_D = 30\text{ A}; V_{GS} = 10\text{ V}; R_G = 4.7\text{ }\Omega$	-	20	-	ns
$t_r$	rise time		-	85	-	ns
$t_{d(off)}$	turn-off delay time		-	95	-	ns
$t_f$	fall time		-	20	-	ns
<b>Source-drain (reverse) diode</b>						
$V_{SD}$	source-drain (diode forward) voltage	$I_S = 60\text{ A}; V_{GS} = 0\text{ V}$ ; <b>Figure 12</b>	-	0.85	1.1	V
$t_{rr}$	reverse recovery time	$I_S = 60\text{ A}; dI_S/dt = -50\text{ A}/\mu\text{s}; V_{GS} = 0\text{ V}$	-	50	-	ns



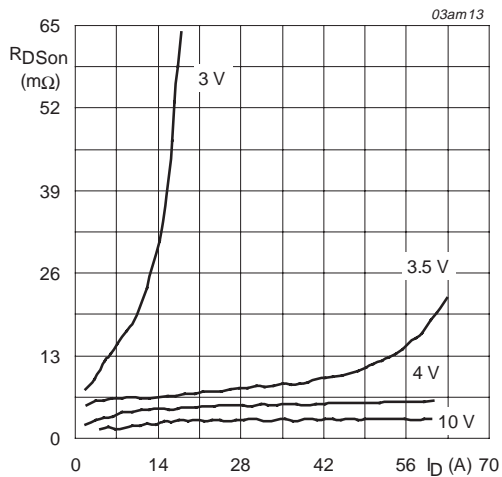
$T_j = 25\text{ }^\circ\text{C}$

**Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.**



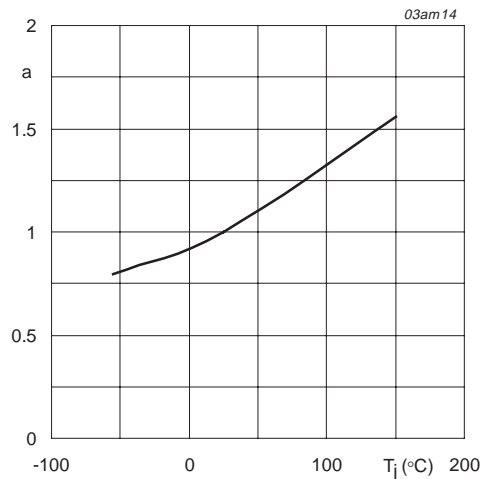
$T_j = 25\text{ }^\circ\text{C}$  and  $150\text{ }^\circ\text{C}$ ;  $V_{DS} > I_D \times R_{DSon}$

**Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.**



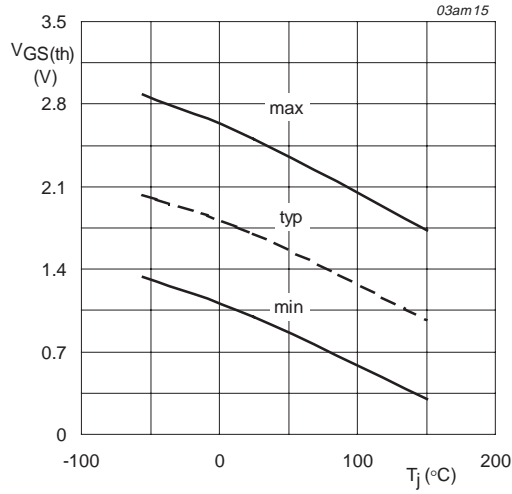
$T_j = 25\text{ }^\circ\text{C}$

**Fig 7. Drain-source on-state resistance as a function of drain current; typical values.**



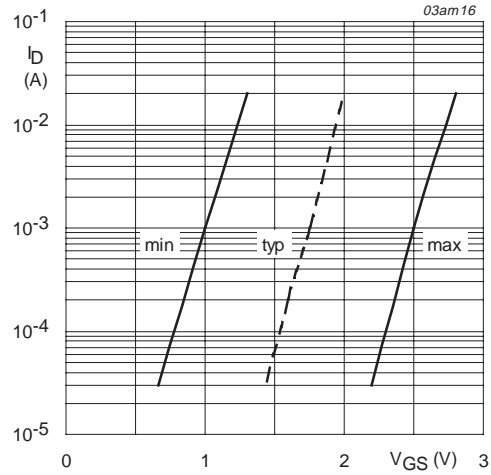
$$a = \frac{R_{DSon}}{R_{DSon}(25^\circ\text{C})}$$

**Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.**



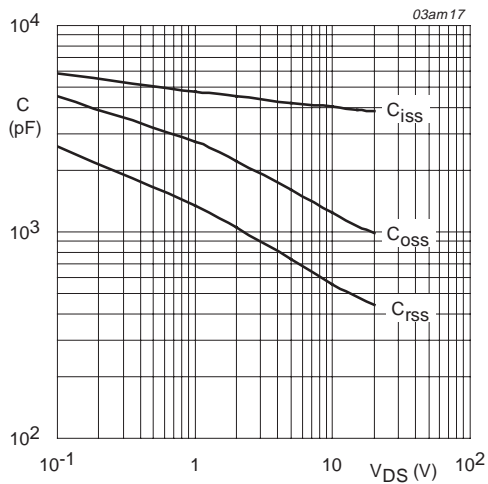
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

**Fig 9. Gate-source threshold voltage as a function of junction temperature.**



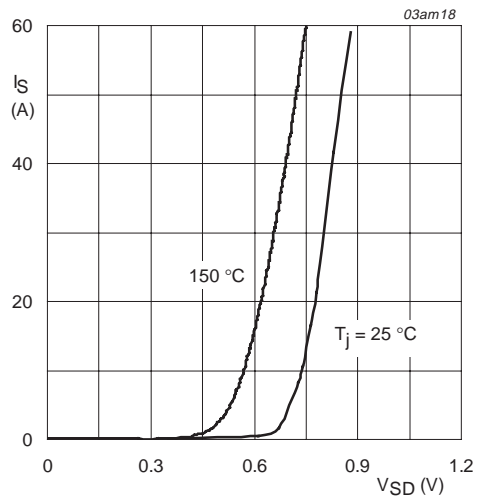
$T_J = 25 \text{ }^\circ\text{C}$

**Fig 10. Sub-threshold drain current as a function of gate-source voltage.**



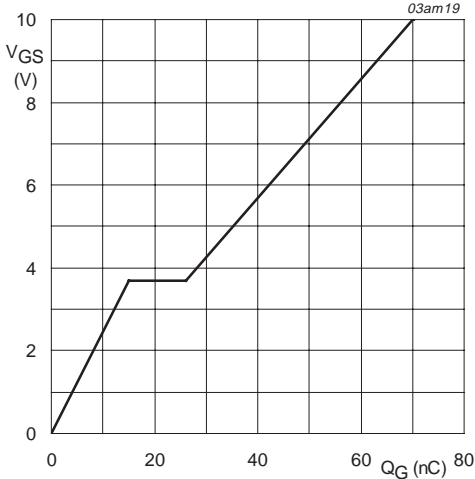
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

**Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.**



$T_J = 25 \text{ }^\circ\text{C}$  and  $150 \text{ }^\circ\text{C}; V_{GS} = 0 \text{ V}$

**Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.**



$T_j = 25\text{ }^\circ\text{C}; I_D = 60\text{ A}; V_{DD} = 10\text{ V}$

Fig 13. Gate-source voltage as a function of gate charge; typical values.



6. Package outline

Plastic single-ended surface mounted package (Philips version LPAK); 4 leads

SOT669

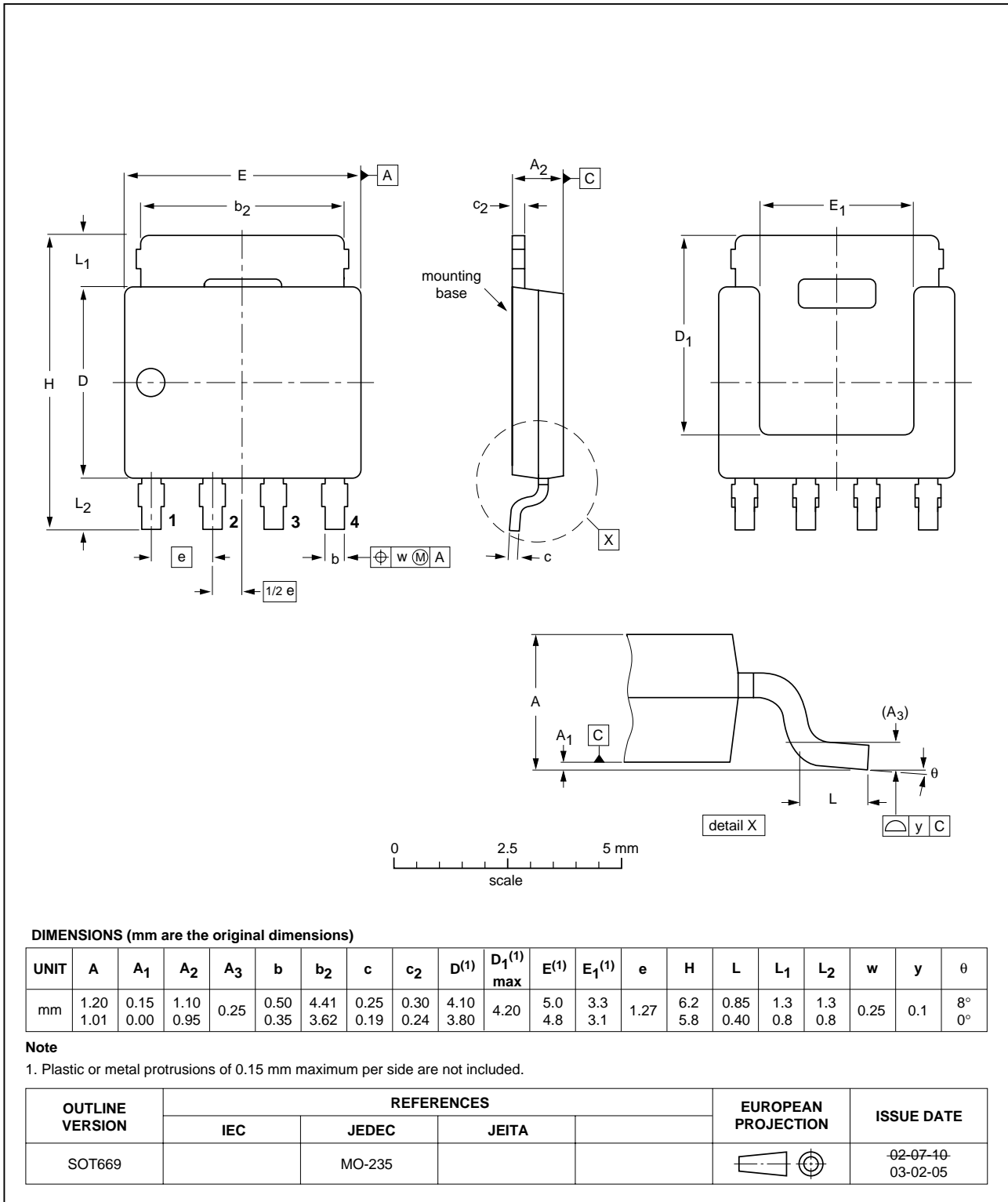


Fig 14. SOT669 (LPAK).

## 7. Revision history

Table 5: Revision history

Rev	Date	CPCN	Description
01	20030613		Product data (9397 750 11119)

## 8. Data sheet status

Level	Data sheet status <sup>[1]</sup>	Product status <sup>[2][3]</sup>	Definition
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